

• General Description

The TFD080N04N combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

• Features

Advance high cell density Trench technology
Low $R_{DS(ON)}$ to minimize conductive loss
Low Gate Charge for fast switching
Dual DIE in one package

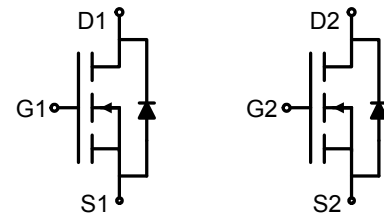


• Product Summary

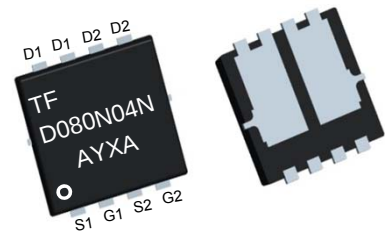
$V_{DS}=40V$, $I_D=40A$

$R_{DS(ON)TYP}=8.0m\Omega$ @ $V_{GS}=10V$

$R_{DS(ON)TYP}=12m\Omega$ @ $V_{GS}=4.5V$



Schematic diagram



PDFN5x6-8L

•Application

Power Management in Notebook Computer,
Portable Equipment and Battery Powered Systems

•Ordering Information:

Part NO.	TFD080N04N
Marking1	D080N04N
Marking2	TF:tuofeng; Y:year code; X:Week; AA:device code;
Basic ordering unit (pcs)	5000

•Absolute Maximum Ratings ($T_c=25^{\circ}C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_{D@TC=25^{\circ}C}$	40	A
	$I_{D@TC=75^{\circ}C}$	28	A
	$I_{D@TC=100^{\circ}C}$	24	A
Pulsed Drain Current ^①	I_{DM}	100	A
Total Power Dissipation	$P_D@TC=25^{\circ}C$	60	W
Total Power Dissipation	$P_D@TA=25^{\circ}C$	1.8	W
Operating Junction Temperature	T_J	-55 to 150	$^{\circ}C$
Storage Temperature	T_{STG}	-55 to 150	$^{\circ}C$
Single Pulse Avalanche Energy	E_{AS}	66	mJ

Avalanche Current	$I_{AS} I_{AR}$	23	A
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●Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	3.5	° C/W
Thermal resistance, junction - ambient	R_{thJA}	-	-	60	° C/W
Soldering temperature, wavesoldering for 8s	T_{sold}	-	-	265	° C

●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	40			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu A$	1.2	1.5	2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS} = 40V, V_{GS} = 0V$			1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			± 100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 20A$		8.0	9.5	$m\Omega$
		$V_{GS} = 4.5V, I_D = 15A$		12	15	$m\Omega$
Forward Transconductance	g_{FS}	$V_{DS} = 25V, I_D = 10A$		10		s

●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C_{iss}	$f = 1MHz$	-	1235	-	pF
Output capacitance	C_{oss}		-	152.5	-	
Reverse transfer capacitance	C_{rss}		-	138.5	-	

●Gate Charge characteristics($T_a = 25^\circ C$)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q_g	$V_{DD} = 20V$	-	25.5	-	nC
Gate - Source charge	Q_{gs}	$I_D = 20A$	-	3.20	-	
Gate - Drain charge	Q_{gd}	$V_{GS} = 10V$	-	6.50	-	

Note: ① Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$;

Fig.1 Power Dissipation

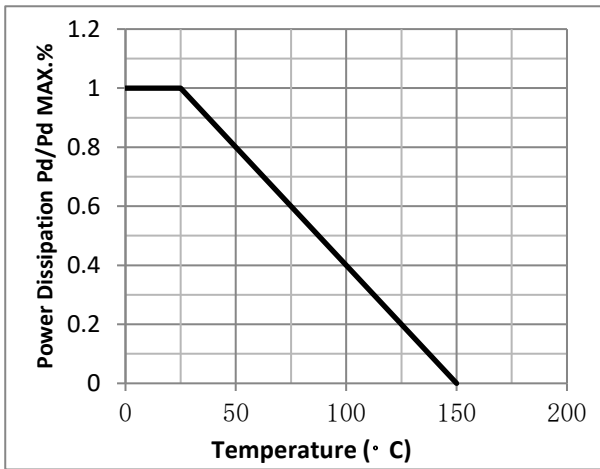


Fig.2 Typical output Characteristics

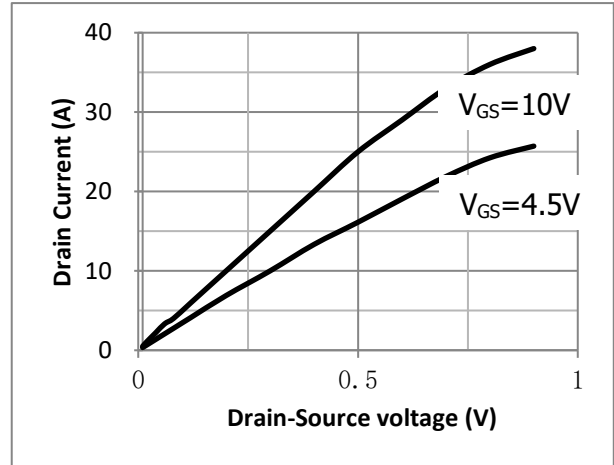


Fig.3 Threshold Voltage V.S Junction Temperature

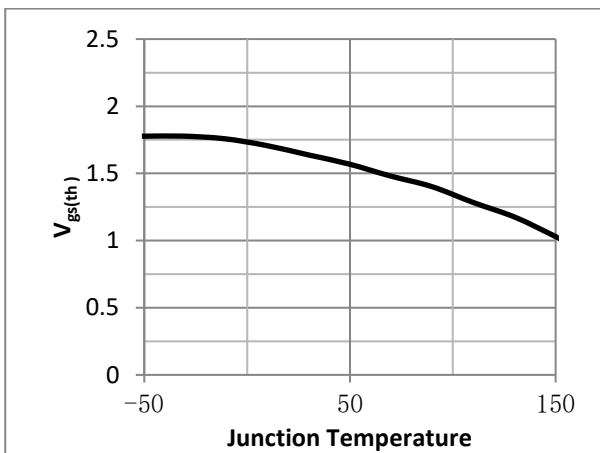


Fig.4 Resistance V.S Drain Current

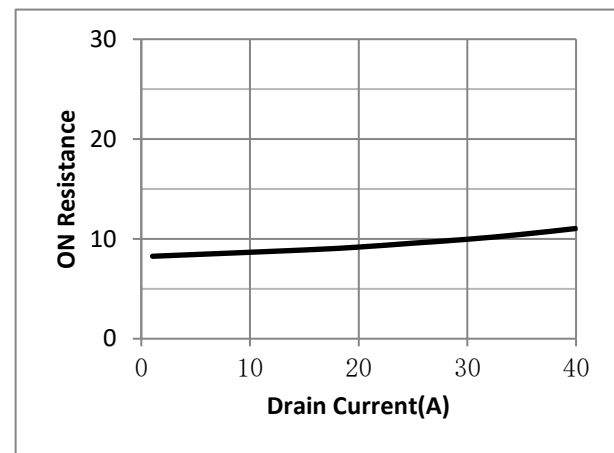


Fig.5 On-Resistance VS Gate Source Voltage

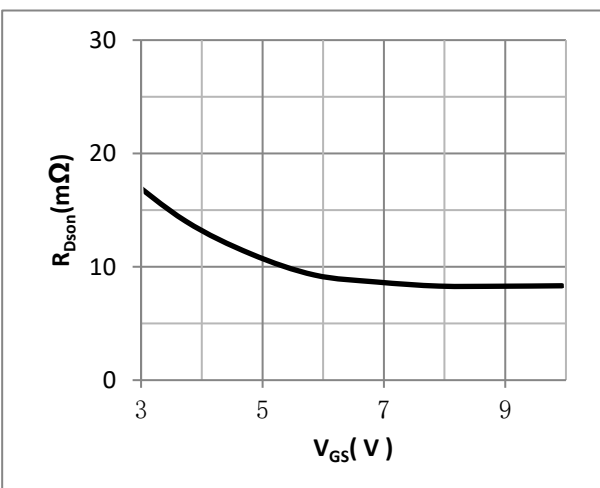


Fig.6 On-Resistance V.S Junction Temperature

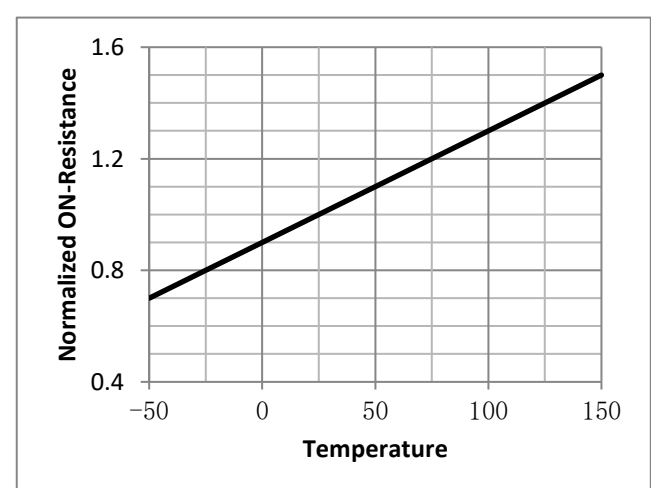


Fig.7 Switching Time Measurement Circuit

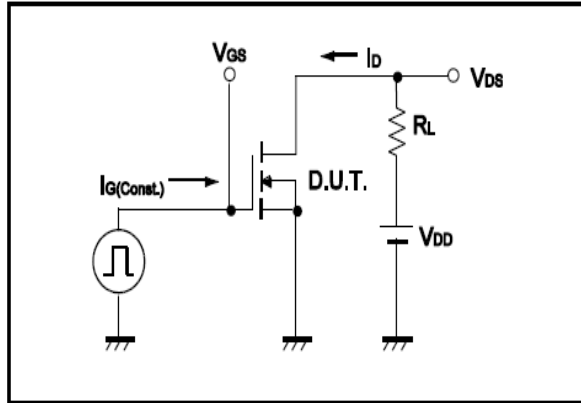


Fig.8 Gate Charge Waveform

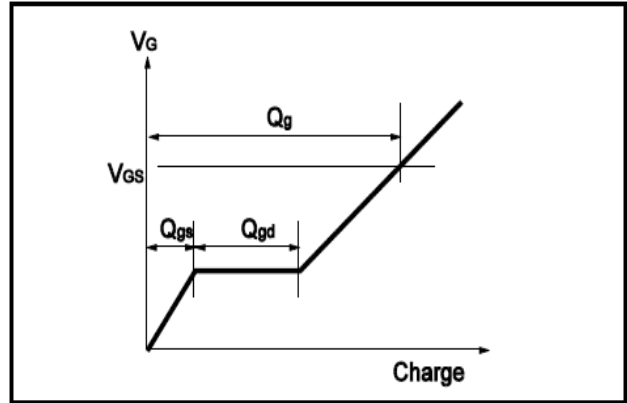


Fig.9 Switching Time Measurement Circuit

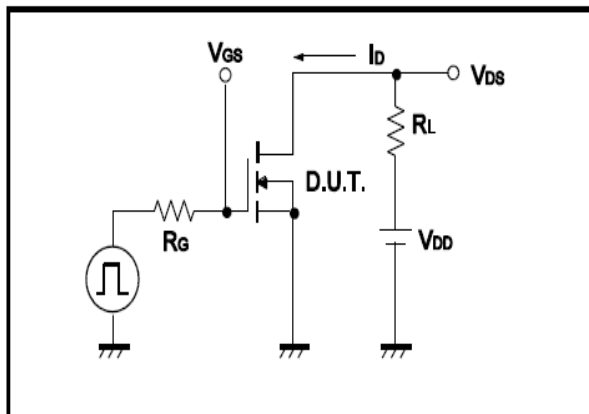


Fig.10 Gate Charge Waveform

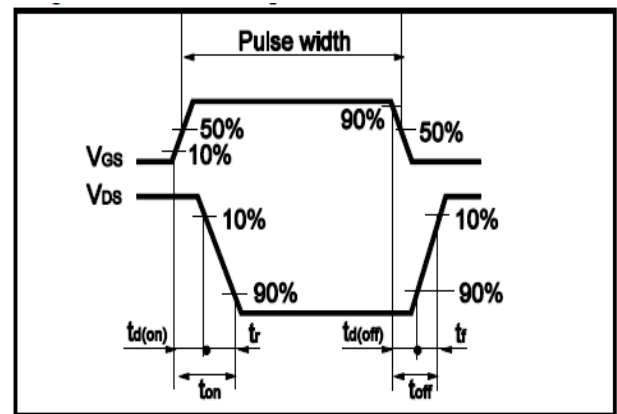


Fig.11 Avalanche Measurement Circuit

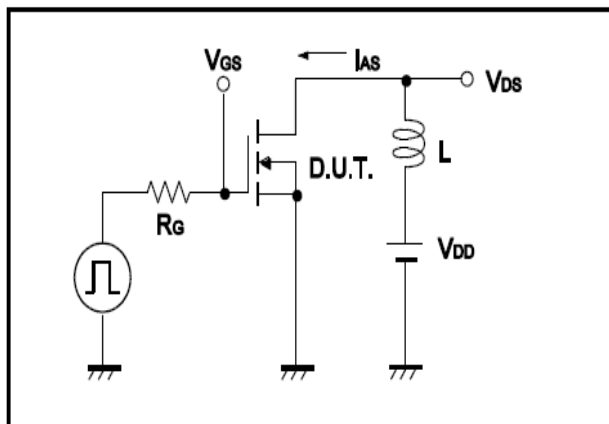
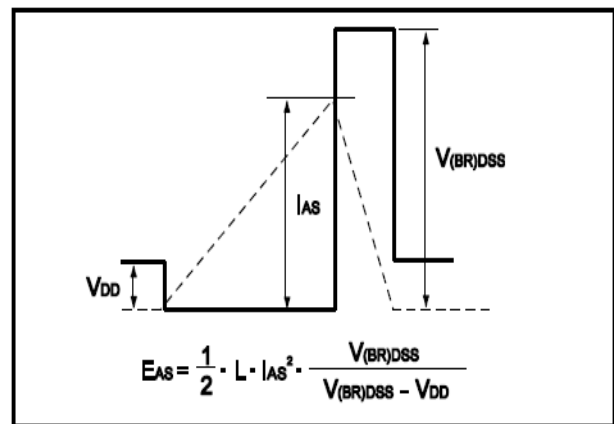
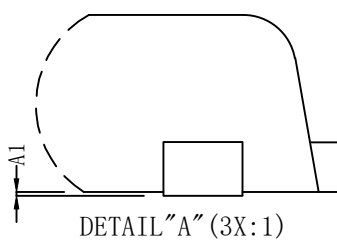
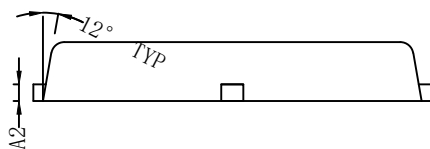
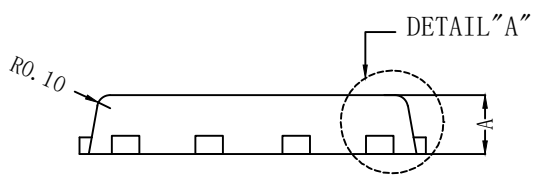
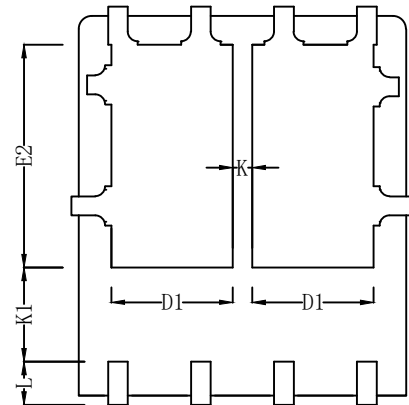
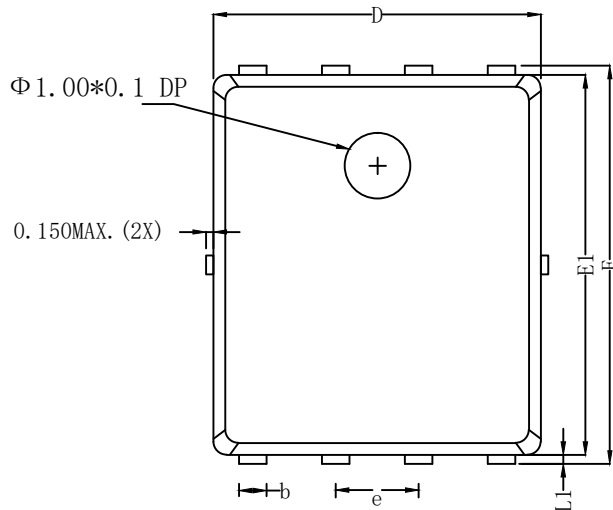


Fig.12 Avalanche Waveform



PDFN5x6-8L Package Outline Dimensions



Dimensions In Millimeter			
Symbol	MIN	TYP	MAX
A	0.90	1.00	1.10
A1	0.00	0.03	0.05
A2	0.254REF		
b	0.25	0.30	0.35
D	4.80	4.90	5.00
D1	1.60	1.70	1.80
E	5.90	6.00	6.10
E1	5.65	5.75	5.85
E2	3.38	3.48	3.58
e	1.27BSC		
K	0.55	0.60	0.65
K1	1.35REF		
L	0.55	0.60	0.65
L1	0.10	0.13	0.16